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What is "[Embedded - Microcontrollers](#)"?

"[Embedded - Microcontrollers](#)" refer to small, integrated circuits designed to perform specific tasks within larger systems. These microcontrollers are essentially compact computers on a single chip, containing a processor core, memory, and programmable input/output peripherals. They are called "embedded" because they are embedded within electronic devices to control various functions, rather than serving as standalone computers. Microcontrollers are crucial in modern electronics, providing the intelligence and control needed for a wide range of applications.

Applications of "[Embedded - Microcontrollers](#)"

Details

Product Status	Active
Core Processor	ARM® Cortex®-M4
Core Size	32-Bit Single-Core
Speed	168MHz
Connectivity	CANbus, I ² C, SPI, UART/USART
Peripherals	DMA, LVD, POR, PWM, WDT
Number of I/O	48
Program Memory Size	64KB (64K x 8)
Program Memory Type	FLASH
EEPROM Size	-
RAM Size	16K x 8
Voltage - Supply (Vcc/Vdd)	1.71V ~ 3.6V
Data Converters	A/D 29x12b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 105°C (TA)
Mounting Type	Surface Mount
Package / Case	64-LQFP
Supplier Device Package	64-LQFP (10x10)
Purchase URL	https://www.e-xfl.com/product-detail/nxp-semiconductors/mkv42f64vlh16

General

- Pin Group 4: XTAL, EXTAL
 - Pin Group 5: DAC analog output
2. Continuous clamp current per pin is -2.0 mA

2 General

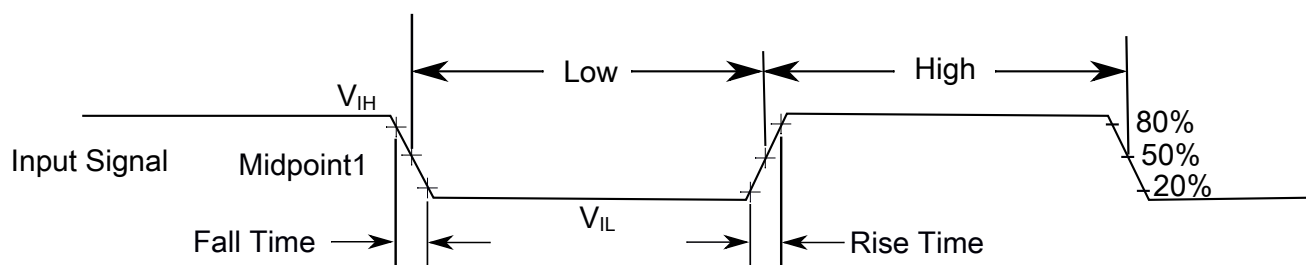
Electromagnetic compatibility (EMC) performance depends on the environment in which the MCU resides. Board design and layout, circuit topology choices, location, characteristics of external components, and MCU software operation play a significant role in EMC performance.

See the following applications notes available on nxp.com for guidelines on optimizing EMC performance.

- *AN2321: Designing for Board Level Electromagnetic Compatibility*
- *AN1050: Designing for Electromagnetic Compatibility (EMC) with HCMOS Microcontrollers*
- *AN1263: Designing for Electromagnetic Compatibility with Single-Chip Microcontrollers*
- *AN2764: Improving the Transient Immunity Performance of Microcontroller-Based Applications*
- *AN1259: System Design and Layout Techniques for Noise Reduction in MCU-Based Systems*

2.1 AC electrical characteristics

Unless otherwise specified, propagation delays are measured from the 50% to the 50% point, and rise and fall times are measured at the 20% and 80% points, as shown in the following figure.



The midpoint is $V_{IL} + (V_{IH} - V_{IL}) / 2$

Figure 2. Input signal measurement reference

Table 5. Power mode transition operating behaviors

Symbol	Description	Min.	Typ.	Max.	Unit	Notes
t_{POR}	After a POR event, amount of time from the point V_{DD} reaches 1.71 V to execution of the first instruction across the operating temperature range of the chip.	—	—	300	μs	
	• VLLS0 → RUN	—	—	173	μs	
	• VLLS1 → RUN	—	—	172	μs	
	• VLLS2 → RUN	—	—	96	μs	
	• VLLS3 → RUN	—	—	96	μs	
	• VLPS → RUN	—	—	5.4	μs	
	• STOP → RUN	—	—	5.4	μs	

2.2.5 Power consumption operating behaviors

NOTE

The maximum values represent characterized results equivalent to the mean plus three times the standard deviation (mean+3 σ)

Table 6. Power consumption operating behaviors (All IDD's are Target values)

Symbol	Description	Min.	Typ.	Max.	Unit	Notes
I_{DD_RUN}	Run mode current — all peripheral clocks disabled, code executing from flash, excludes IDDA					Core frequency of 25 MHz.
	• @ 1.8V	—	6.8	17.2	mA	
	• @ 3.0V	—	6.9	17.4	mA	
I_{DD_RUN}	Run mode current — all peripheral clocks disabled, code executing from flash, excludes IDDA					Core frequency of 50 MHz.
	• @ 1.8V					
	• @ 3.0V	—	9.9	19.7	mA	

Table continues on the next page...

Table 6. Power consumption operating behaviors (All IDD's are Target values) (continued)

Symbol	Description	Min.	Typ.	Max.	Unit	Notes
		—	10.0	19.8	mA	
I _{DD_RUN}	Run mode current — all peripheral clocks disabled, code executing from flash, excludes IDDA • @ 1.8V • @ 3.0V	—	17.0	25.9	mA	Core frequency of 100 MHz.
		—	17.2	26.1	mA	
I _{DD_HSRUN}	Run mode current — all peripheral clocks disabled, code executing from flash, excludes IDDA • @ 1.8V • @ 3.0V	—	26.3	45.3	mA	Core frequency of 168 MHz.
		—	26.5	45.5	mA	
I _{DD_HSRUN}	Run mode current — all peripheral clocks enabled, code executing from flash,excludes IDDA • @ 3.0V • @ 25°C • @ 105°C	—	34.0	45.5	mA	Core frequency of 168 MHz. Nanoedge module at 84 MHz.
		—	39.0	53.2	mA	
I _{DD_WAIT}	Wait mode high frequency current at 3.0 V — all peripheral clocks disabled	—	8.9	—	mA	
I _{DD_VLPR}	Very-low-power run mode current at 3.0 V — all peripheral clocks disabled	—	0.58	—	mA	Core frequency of 4 Mhz.
I _{DD_VLPR}	Very-low-power run mode current at 3.0 V — all peripheral clocks enabled	—	0.83	—	mA	Core frequency of 4 Mhz.
I _{DD_VLPW}	Very-low-power wait mode current at 3.0 V — all peripheral clocks disabled	—	0.34	—	mA	Bus frequency of 2 MHz.
I _{DD_STOP}	Stop mode current at 3.0 V • @ –40 to 25°C • @ 70°C • @ 105°C	—	0.43	2.03	mA	
		—	1.16	4.27	mA	
		—	3.05	10.13	mA	
I _{DD_VLPS}	Very-low-power stop mode current at 3.0 V • @ –40 to 25°C • @ 70°C • @ 105°C	—	58	218	μA	
		—	280	1340	μA	
		—	924	2870	μA	
I _{DD_VLLS3}	Very low-leakage stop mode 3 current at 3.0 V • @ –40 to 25°C • @ 70°C • @ 105°C	—	2.8	5.3	μA	
		—	9.6	35.1	μA	
		—	37.4	134.8	μA	
I _{DD_VLLS2}	Very low-leakage stop mode 2 current at 3.0 V					

Table continues on the next page...

General

1. Determined according to IEC Standard 61967-1, *Integrated Circuits - Measurement of Electromagnetic Emissions, 150 kHz to 1 GHz Part 1: General Conditions and Definitions* and IEC Standard 61967-2, *Integrated Circuits - Measurement of Electromagnetic Emissions, 150 kHz to 1 GHz Part 2: Measurement of Radiated Emissions—TEM Cell and Wideband TEM Cell Method*. Measurements were made while the microcontroller was running basic application code. The reported emission level is the value of the maximum measured emission, rounded up to the next whole number, from among the measured orientations in each frequency range.
2. $V_{DD} = 3.3\text{ V}$, $T_A = 25\text{ }^{\circ}\text{C}$, $f_{OSC} = 10\text{ MHz}$ (crystal), $f_{SYS} = 75\text{ MHz}$, $f_{BUS} = 25\text{ MHz}$
3. Specified according to Annex D of IEC Standard 61967-2, *Measurement of Radiated Emissions—TEM Cell and Wideband TEM Cell Method*

2.2.7 Designing with radiated emissions in mind

To find application notes that provide guidance on designing your system to minimize interference from radiated emissions:

1. Go to www.nxp.com.
2. Perform a keyword search for “EMC design.”

2.2.8 Capacitance attributes

Table 9. Capacitance attributes

Symbol	Description	Min.	Max.	Unit
C_{IN_A}	Input capacitance: analog pins	—	7	pF
C_{IN_D}	Input capacitance: digital pins	—	7	pF

2.3 Switching specifications

2.3.1 Typical device clock specifications

Table 10. Typical device clock specifications

Symbol	Description	Min.	Max.	Unit	Notes
High Speed RUN mode					
f_{SYS}	System and core clock	—	168	MHz	
f_{BUS}	Bus and Flash clock	—	24	MHz	
f_{FPC}	Fast peripheral clock	—	84	MHz	
f_{NANO}	Nano-edge clock	—	168	MHz	
Normal run mode					
f_{SYS}	System and core clock	—	100	MHz	
f_{BUS}	Bus and Flash clock	—	25	MHz	

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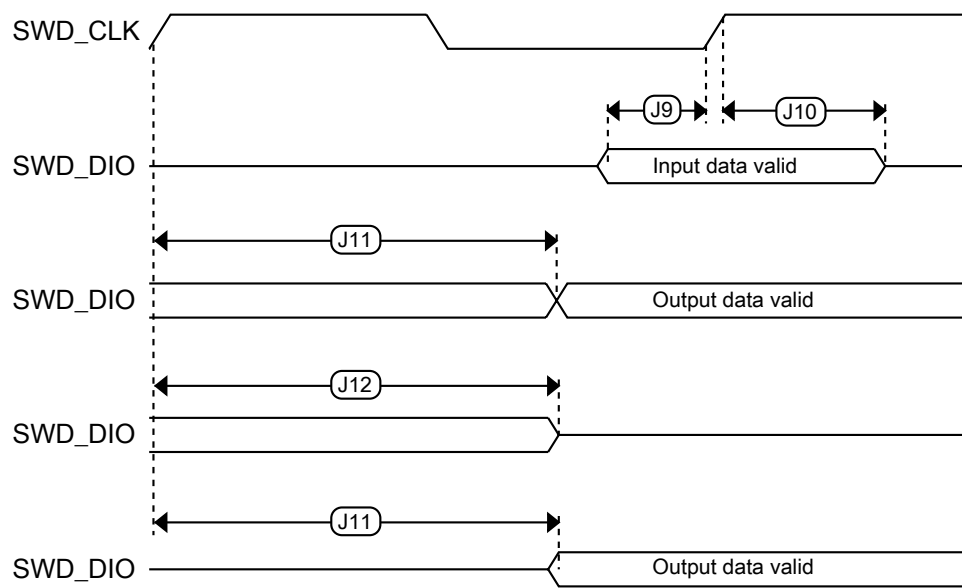


Figure 6. Serial wire data timing

3.1.2 Debug trace timing specifications

Table 15. Debug trace operating behaviors

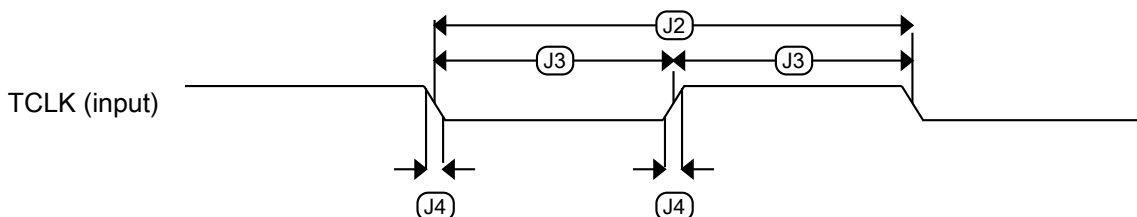
Symbol	Description	Min.	Max.	Unit
T_{cyc}	Clock period	Frequency dependent		MHz
T_{wl}	Low pulse width	2	—	ns
T_{wh}	High pulse width	2	—	ns
T_r	Clock and data rise time	—	3	ns
T_f	Clock and data fall time	—	3	ns
T_s	Data setup	3	1.5	ns
T_h	Data hold	2	1.0	ns

Table 16. JTAG limited voltage range electricals (continued)

Symbol	Description	Min.	Max.	Unit
J11	TCLK low to TDO data valid	—	19	ns
J12	TCLK low to TDO high-Z	—	17	ns
J13	$\overline{\text{TRST}}$ assert time	100	—	ns
J14	$\overline{\text{TRST}}$ setup time (negation) to TCLK high	8	—	ns

Table 17. JTAG full voltage range electricals

Symbol	Description	Min.	Max.	Unit
	Operating voltage	1.71	3.6	V
J1	TCLK frequency of operation • Boundary Scan • JTAG and CJTAG • Serial Wire Debug	0 0 0	10 20 40	MHz
J2	TCLK cycle period	1/J1	—	ns
J3	TCLK clock pulse width • Boundary Scan • JTAG and CJTAG • Serial Wire Debug	50 25 12.5	— — —	ns ns ns
J4	TCLK rise and fall times	—	3	ns
J5	Boundary scan input data setup time to TCLK rise	20	—	ns
J6	Boundary scan input data hold time after TCLK rise	2.0	—	ns
J7	TCLK low to boundary scan output data valid	—	30.6	ns
J8	TCLK low to boundary scan output high-Z	—	25	ns
J9	TMS, TDI input data setup time to TCLK rise	8	—	ns
J10	TMS, TDI input data hold time after TCLK rise	1.0	—	ns
J11	TCLK low to TDO data valid	—	19.0	ns
J12	TCLK low to TDO high-Z	—	17.0	ns
J13	$\overline{\text{TRST}}$ assert time	100	—	ns
J14	$\overline{\text{TRST}}$ setup time (negation) to TCLK high	8	—	ns

**Figure 9. Test clock input timing**

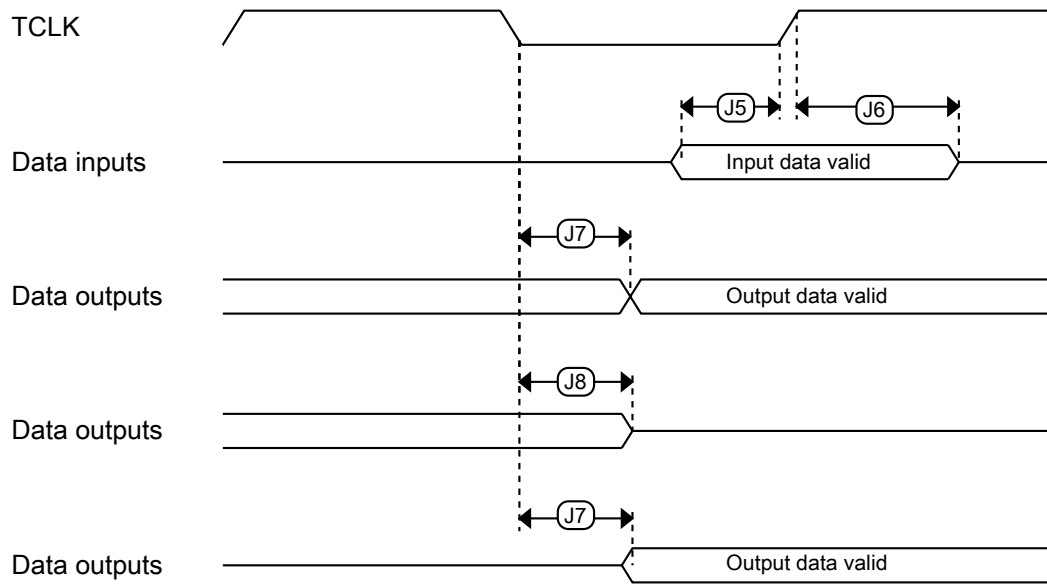


Figure 10. Boundary scan (JTAG) timing

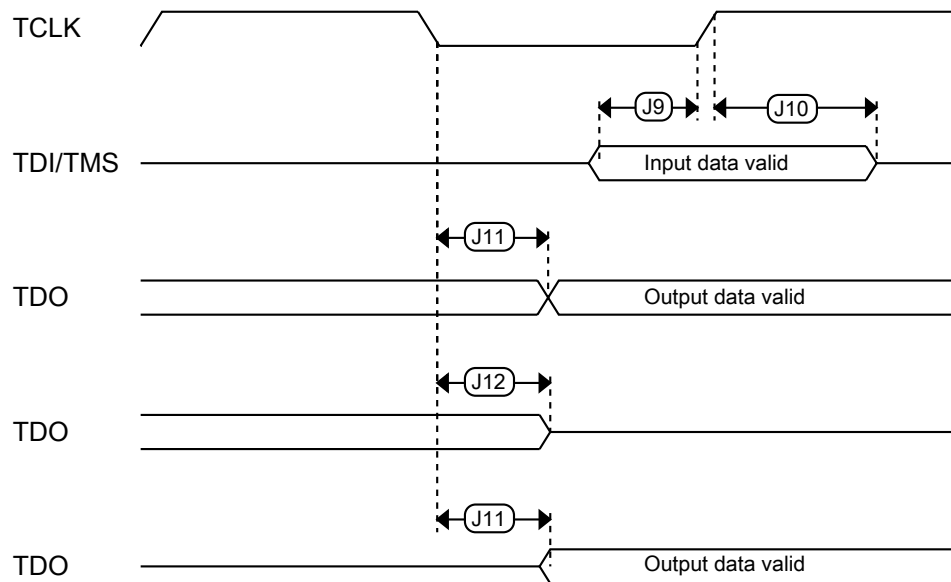


Figure 11. Test Access Port timing

3.5 Security and integrity modules

There are no specifications necessary for the device's security and integrity modules.

3.6 Analog

3.6.1 12-bit cyclic Analog-to-Digital Converter (ADC) parameters

NOTE

The maximum values represent characterized results equivalent to the mean plus three times the standard deviation (mean+3 σ).

Table 25. 12-bit ADC electrical specifications

Characteristic	Symbol	Min	Typ	Max	Unit
Recommended Operating Conditions					
Supply Voltage ¹	V _{DDA}	2.7	3.3	3.6	V
V _{refh} Supply Voltage ²	V _{refhx}	2.7		V _{DDA}	V
ADC Conversion Clock ³	f _{ADCCLK}	0.6		25	MHz
Conversion Range	R _{AD}	V _{REFL}		V _{REFH}	V
Input Voltage Range	V _{ADIN}				V
External Reference		V _{REFL}		V _{REFH}	
Internal Reference		V _{SSA}		V _{DDA}	
Timing and Power					
Conversion Time	t _{ADC}		6		ADC Clock Cycles
ADC Power-Up Time (from adc_pdn)	t _{ADPU}		13		ADC Clock Cycles
ADC RUN Current (per ADC block)	I _{ADRUN}				mA
- at 600 kHz ADC Clock, LP mode ≤ 8.33 MHz ADC Clock, 00 mode ≤ 12.5 MHz ADC Clock, 01 mode ≤ 16.67 MHz ADC Clock, 10 mode ≤ 20 MHz ADC Clock, 11 mode ≤ 25 MHz ADC Clock			1 5.7 10.5 17.7 22.6 27.5		
ADC Powerdown Current (adc_pdn enabled)	I _{ADPWRDWN}		0.02		μA
V _{REFH} Current	I _{VREFH}		0.001		μA
Accuracy (DC or Absolute)					
Integral non-Linearity ⁴	INL		+/- 3	+/- 5	LSB ⁵
Differential non-Linearity ⁴	DNL		+/- 0.6	+/- 0.9	LSB ⁵

Table continues on the next page...

- SIN: PTC7
- SOUT: PTC6

Table 31. Master mode DSPI timing for normal pads (limited voltage range)

Num	Description	Min.	Max.	Unit	Notes
	Operating voltage	2.7	3.6	V	
	Frequency of operation	—	25	MHz	
DS1	DSPI_SCK output cycle time	$2 \times t_{\text{BUS}}$	—	ns	
DS2	DSPI_SCK output high/low time	$(t_{\text{SCK}}/2) - 2$	$(t_{\text{SCK}}/2) + 2$	ns	
DS3	DSPI_PCS _n to DSPI_SCK output valid	$(t_{\text{BUS}} \times 2) - 2$	—	ns	1
DS4	DSPI_SCK to DSPI_PCS _n output hold	$(t_{\text{BUS}} \times 2) - 2$	—	ns	2
DS5	DSPI_SCK to DSPI_SOUT valid	—	8.5	ns	
DS6	DSPI_SCK to DSPI_SOUT invalid	-2	—	ns	
DS7	DSPI_SIN to DSPI_SCK input setup	17	—	ns	
DS8	DSPI_SCK to DSPI_SIN input hold	0	—	ns	

1. The delay is programmable in SPIx_CTARn[PSSCK] and SPIx_CTARn[CSSCK].
2. The delay is programmable in SPIx_CTARn[PASC] and SPIx_CTARn[ASC].

Table 32. Master mode DSPI timing for fast pads (limited voltage range)

Num	Description	Min.	Max.	Unit	Notes
	Operating voltage	2.7	3.6	V	
	Frequency of operation	—	37.5	MHz	
DS1	DSPI_SCK output cycle time	$2 \times t_{\text{BUS}}$	—	ns	
DS2	DSPI_SCK output high/low time	$(t_{\text{SCK}}/2) - 2$	$(t_{\text{SCK}}/2) + 2$	ns	
DS3	DSPI_PCS _n to DSPI_SCK output valid	$(t_{\text{BUS}} \times 2) - 2$	—	ns	1
DS4	DSPI_SCK to DSPI_PCS _n output hold	$(t_{\text{BUS}} \times 2) - 2$	—	ns	2
DS5	DSPI_SCK to DSPI_SOUT valid	—	8.5	ns	
DS6	DSPI_SCK to DSPI_SOUT invalid	-2	—	ns	
DS7	DSPI_SIN to DSPI_SCK input setup	13	—	ns	
DS8	DSPI_SCK to DSPI_SIN input hold	0	—	ns	

1. The delay is programmable in SPIx_CTARn[PSSCK] and SPIx_CTARn[CSSCK].
2. The delay is programmable in SPIx_CTARn[PASC] and SPIx_CTARn[ASC].

Table 33. Master mode DSPI timing for open drain pads (limited voltage range)

Num	Description	Min.	Max.	Unit	Notes
	Operating voltage	2.7	3.6	V	

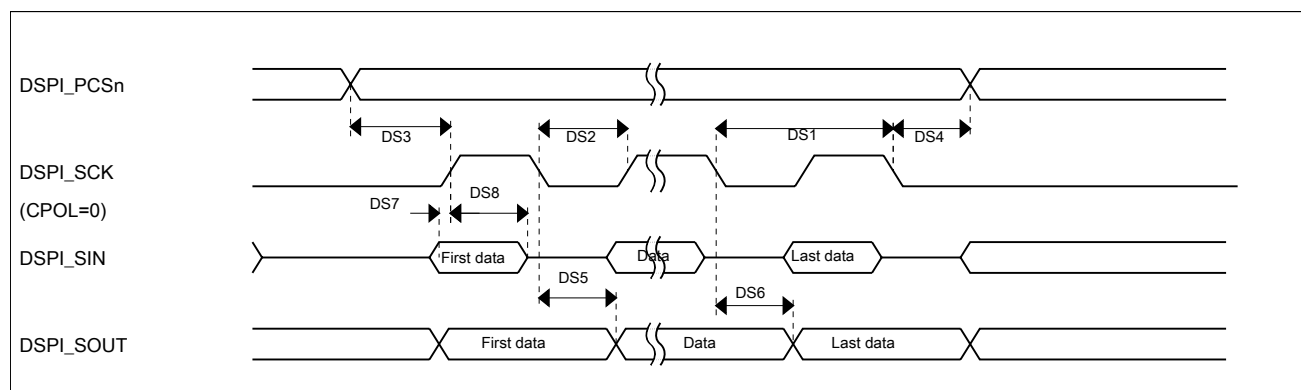
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Table 33. Master mode DSPI timing for open drain pads (limited voltage range) (continued)

Num	Description	Min.	Max.	Unit	Notes
	Frequency of operation	—	25	MHz	
DS1	DSPI_SCK output cycle time	$2 \times t_{\text{BUS}}$	—	ns	
DS2	DSPI_SCK output high/low time	$(t_{\text{SCK}}/2) - 2$	$(t_{\text{SCK}}/2) + 2$	ns	
DS3	DSPI_PCSn to DSPI_SCK output valid	$(t_{\text{BUS}} \times 2) - 2$	—	ns	1
DS4	DSPI_SCK to DSPI_PCSn output hold	$(t_{\text{BUS}} \times 2) - 2$	—	ns	2
DS5	DSPI_SCK to DSPI_SOUT valid	—	15.5	ns	
DS6	DSPI_SCK to DSPI_SOUT invalid	-3	—	ns	
DS7	DSPI_SIN to DSPI_SCK input setup	17	—	ns	
DS8	DSPI_SCK to DSPI_SIN input hold	0	—	ns	

1. The delay is programmable in SPIx_CTARn[PSSCK] and SPIx_CTARn[CSSCK].

2. The delay is programmable in SPIx_CTARn[PASC] and SPIx_CTARn[ASC].

**Figure 18. DSPI classic SPI timing — master mode****Table 34. Slave mode DSPI timing for normal pads (limited voltage range)**

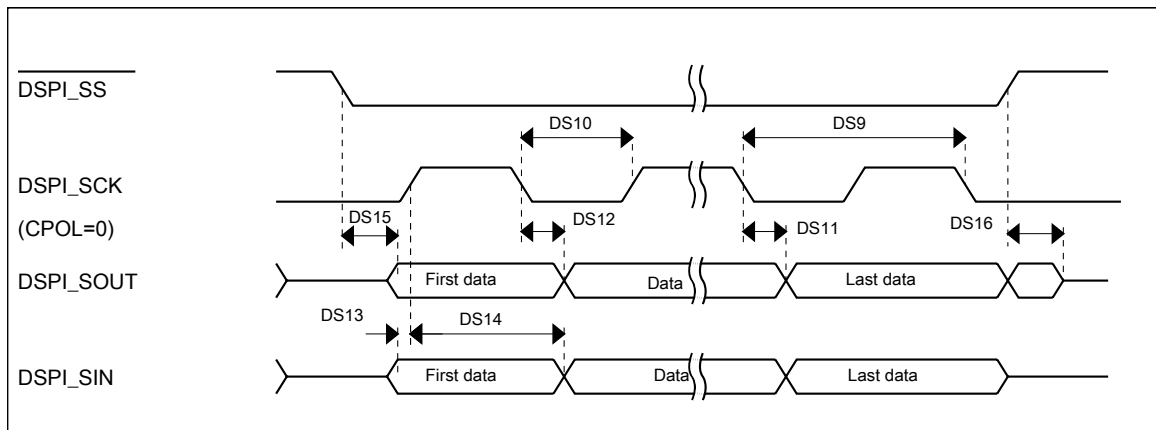
Num	Description	Min.	Max.	Unit
	Operating voltage	2.7	3.6	V
	Frequency of operation		12.5	MHz
DS9	DSPI_SCK input cycle time	$4 \times t_{\text{BUS}}$	—	ns
DS10	DSPI_SCK input high/low time	$(t_{\text{SCK}}/2) - 2$	$(t_{\text{SCK}}/2) + 2$	ns
DS11	DSPI_SCK to DSPI_SOUT valid	—	21	ns
DS12	DSPI_SCK to DSPI_SOUT invalid	0	—	ns
DS13	DSPI_SIN to DSPI_SCK input setup	2	—	ns
DS14	DSPI_SCK to DSPI_SIN input hold	7	—	ns
DS15	DSPI_SS active to DSPI_SOUT driven	—	15	ns
DS16	DSPI_SS inactive to DSPI_SOUT not driven	—	15	ns

Table 35. Slave mode DSPI timing for fast pads (limited voltage range)

Num	Description	Min.	Max.	Unit
	Operating voltage	2.7	3.6	V
	Frequency of operation		25	MHz
DS9	DSPI_SCK input cycle time	$4 \times t_{\text{BUS}}$	—	ns
DS10	DSPI_SCK input high/low time	$(t_{\text{SCK}}/2) - 2$	$(t_{\text{SCK}}/2) + 2$	ns
DS11	DSPI_SCK to DSPI_SOUT valid	—	17	ns
DS12	DSPI_SCK to DSPI_SOUT invalid	0	—	ns
DS13	DSPI_SIN to DSPI_SCK input setup	2	—	ns
DS14	DSPI_SCK to DSPI_SIN input hold	7	—	ns
DS15	$\overline{\text{DSPI_SS}}$ active to DSPI_SOUT driven	—	11	ns
DS16	$\overline{\text{DSPI_SS}}$ inactive to DSPI_SOUT not driven	—	11	ns

Table 36. Slave mode DSPI timing for open drain pads (limited voltage range)

Num	Description	Min.	Max.	Unit
	Operating voltage	2.7	3.6	V
	Frequency of operation		12.5	MHz
DS9	DSPI_SCK input cycle time	$4 \times t_{\text{BUS}}$	—	ns
DS10	DSPI_SCK input high/low time	$(t_{\text{SCK}}/2) - 2$	$(t_{\text{SCK}}/2) + 2$	ns
DS11	DSPI_SCK to DSPI_SOUT valid	—	28	ns
DS12	DSPI_SCK to DSPI_SOUT invalid	0	—	ns
DS13	DSPI_SIN to DSPI_SCK input setup	2	—	ns
DS14	DSPI_SCK to DSPI_SIN input hold	7	—	ns
DS15	$\overline{\text{DSPI_SS}}$ active to DSPI_SOUT driven	—	22	ns
DS16	$\overline{\text{DSPI_SS}}$ inactive to DSPI_SOUT not driven	—	22	ns

**Figure 19. DSPI classic SPI timing — slave mode**

3.9.2 SPI (DSPI) switching specifications (full voltage range)

The DMA Serial Peripheral Interface (DSPI) provides a synchronous serial bus with master and slave operations. Many of the transfer attributes are programmable. The tables below provides DSPI timing characteristics for classic SPI timing modes. Refer to the DSPI chapter of the Reference Manual for information on the modified transfer formats used for communicating with slower peripheral devices.

NOTE

Fast pads:

- SIN: PTE19
- SOUT: PTE18
- SCK: PTE17
- PCS: PTE16

Open drain pads:

- SIN: PTC7
- SOUT: PTC6

Table 37. Master mode DSPI timing for normal pads (full voltage range)

Num	Description	Min.	Max.	Unit	Notes
	Operating voltage	1.71	3.6	V	1
	Frequency of operation	—	18.75	MHz	
DS1	DSPI_SCK output cycle time	$4 \times t_{BUS}$	—	ns	
DS2	DSPI_SCK output high/low time	$(t_{SCK}/2) - 4$	$(t_{SCK}/2) + 4$	ns	
DS3	DSPI_PCS _n valid to DSPI_SCK delay	$(t_{BUS} \times 2) - 4$	—	ns	2
DS4	DSPI_SCK to DSPI_PCS _n invalid delay	$(t_{BUS} \times 2) - 4$	—	ns	3
DS5	DSPI_SCK to DSPI_SOUT valid	—	10	ns	
DS6	DSPI_SCK to DSPI_SOUT invalid	-7.8	—	ns	
DS7	DSPI_SIN to DSPI_SCK input setup	24	—	ns	
DS8	DSPI_SCK to DSPI_SIN input hold	0	—	ns	

1. The DSPI module can operate across the entire operating voltage for the processor, but to run across the full voltage range the maximum frequency of operation is reduced.
2. The delay is programmable in SPIx_CTARn[PSSCK] and SPIx_CTARn[CSSCK].
3. The delay is programmable in SPIx_CTARn[PASC] and SPIx_CTARn[ASC].

Table 38. Master mode DSPI timing fast pads (full voltage range)

Num	Description	Min.	Max.	Unit	Notes
	Operating voltage	1.71	3.6	V	1
	Frequency of operation	—	25	MHz	
DS1	DSPI_SCK output cycle time	$4 \times t_{\text{BUS}}$	—	ns	
DS2	DSPI_SCK output high/low time	$(t_{\text{SCK}}/2) - 4$	$(t_{\text{SCK}}/2) + 4$	ns	
DS3	DSPI_PCS _n valid to DSPI_SCK delay	$(t_{\text{BUS}} \times 2) - 4$	—	ns	2
DS4	DSPI_SCK to DSPI_PCS _n invalid delay	$(t_{\text{BUS}} \times 2) - 4$	—	ns	3
DS5	DSPI_SCK to DSPI_SOUT valid	—	10	ns	
DS6	DSPI_SCK to DSPI_SOUT invalid	-7.8	—	ns	
DS7	DSPI_SIN to DSPI_SCK input setup	17	—	ns	
DS8	DSPI_SCK to DSPI_SIN input hold	0	—	ns	

1. The DSPI module can operate across the entire operating voltage for the processor, but to run across the full voltage range the maximum frequency of operation is reduced.
2. The delay is programmable in SPIx_CTARn[PSSCK] and SPIx_CTARn[CSSCK].
3. The delay is programmable in SPIx_CTARn[PASC] and SPIx_CTARn[ASC].

Table 39. Master mode DSPI timing open drain pads (full voltage range)

Num	Description	Min.	Max.	Unit	Notes
	Operating voltage	1.71	3.6	V	1
	Frequency of operation	—	18.75	MHz	
DS1	DSPI_SCK output cycle time	$4 \times t_{\text{BUS}}$	—	ns	
DS2	DSPI_SCK output high/low time	$(t_{\text{SCK}}/2) - 4$	$(t_{\text{SCK}}/2) + 4$	ns	
DS3	DSPI_PCS _n valid to DSPI_SCK delay	$(t_{\text{BUS}} \times 2) - 4$	—	ns	2
DS4	DSPI_SCK to DSPI_PCS _n invalid delay	$(t_{\text{BUS}} \times 2) - 4$	—	ns	3
DS5	DSPI_SCK to DSPI_SOUT valid	—	26	ns	
DS6	DSPI_SCK to DSPI_SOUT invalid	-7.8	—	ns	
DS7	DSPI_SIN to DSPI_SCK input setup	24	—	ns	
DS8	DSPI_SCK to DSPI_SIN input hold	0	—	ns	

1. The DSPI module can operate across the entire operating voltage for the processor, but to run across the full voltage range the maximum frequency of operation is reduced.
2. The delay is programmable in SPIx_CTARn[PSSCK] and SPIx_CTARn[CSSCK].
3. The delay is programmable in SPIx_CTARn[PASC] and SPIx_CTARn[ASC].

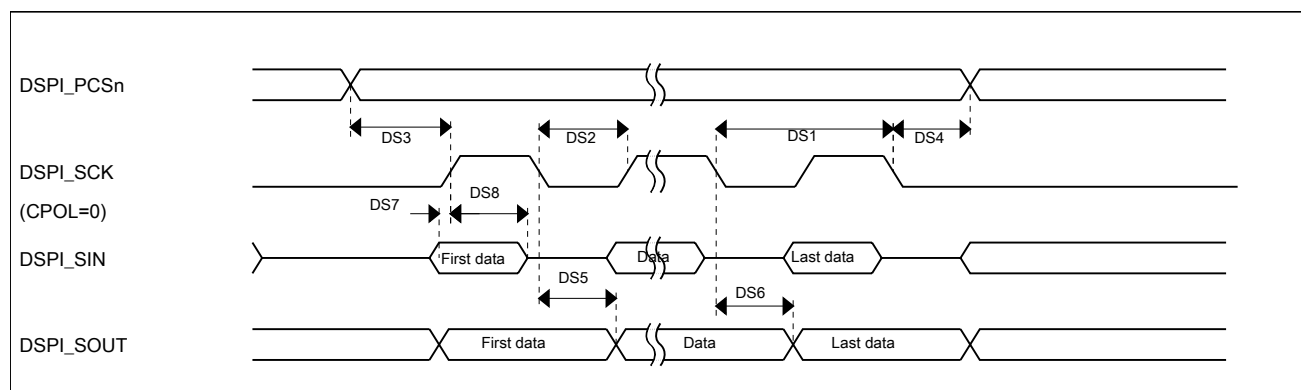


Figure 20. DSPI classic SPI timing — master mode

Table 40. Slave mode DSPI timing for normal pads (full voltage range)

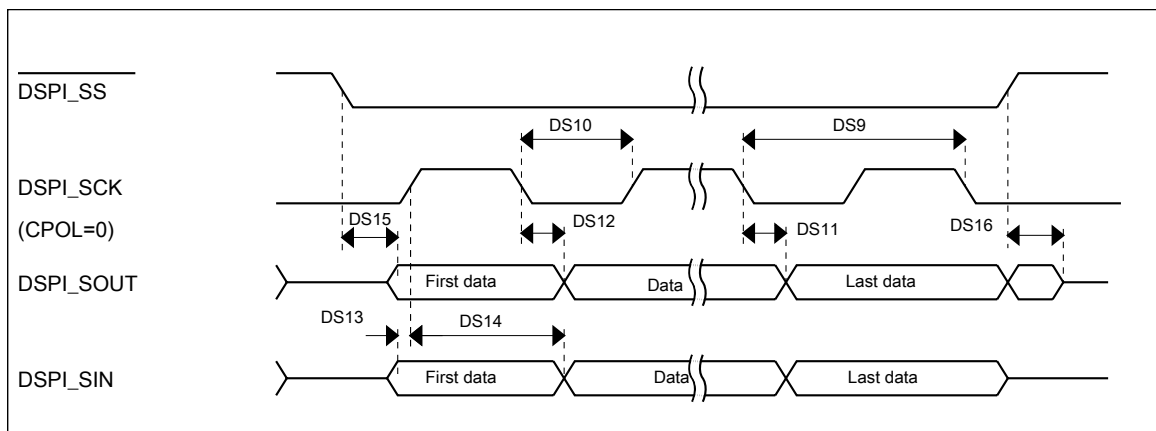
Num	Description	Min.	Max.	Unit
	Operating voltage	1.71	3.6	V
	Frequency of operation	—	12.5	MHz
DS9	DSPI_SCK input cycle time	$8 \times t_{BUS}$	—	ns
DS10	DSPI_SCK input high/low time	$(t_{SCK}/2) - 4$	$(t_{SCK}/2) + 4$	ns
DS11	DSPI_SCK to DSPI_SOUT valid	—	27.5	ns
DS12	DSPI_SCK to DSPI_SOUT invalid	0	—	ns
DS13	DSPI_SIN to DSPI_SCK input setup	2.5	—	ns
DS14	DSPI_SCK to DSPI_SIN input hold	7	—	ns
DS15	DSPI_SS active to DSPI_SOUT driven	—	22	ns
DS16	DSPI_SS inactive to DSPI_SOUT not driven	—	22	ns

Table 41. Slave mode DSPI timing for fast pads (full voltage range)

Num	Description	Min.	Max.	Unit
	Operating voltage	1.71	3.6	V
	Frequency of operation	—	18.75	MHz
DS9	DSPI_SCK input cycle time	$8 \times t_{BUS}$	—	ns
DS10	DSPI_SCK input high/low time	$(t_{SCK}/2) - 4$	$(t_{SCK}/2) + 4$	ns
DS11	DSPI_SCK to DSPI_SOUT valid	—	20.5	ns
DS12	DSPI_SCK to DSPI_SOUT invalid	0	—	ns
DS13	DSPI_SIN to DSPI_SCK input setup	2.5	—	ns
DS14	DSPI_SCK to DSPI_SIN input hold	7	—	ns
DS15	DSPI_SS active to DSPI_SOUT driven	—	15	ns
DS16	DSPI_SS inactive to DSPI_SOUT not driven	—	15	ns

Table 42. Slave mode DSPI timing for open drain pads (full voltage range)

Num	Description	Min.	Max.	Unit
	Operating voltage	1.71	3.6	V
	Frequency of operation	—	9.375	MHz
DS9	DSPI_SCK input cycle time	$8 \times t_{\text{BUS}}$	—	ns
DS10	DSPI_SCK input high/low time	$(t_{\text{SCK}}/2) - 4$	$(t_{\text{SCK}}/2) + 4$	ns
DS11	DSPI_SCK to DSPI_SOUT valid	—	43.5	ns
DS12	DSPI_SCK to DSPI_SOUT invalid	0	—	ns
DS13	DSPI_SIN to DSPI_SCK input setup	2.5	—	ns
DS14	DSPI_SCK to DSPI_SIN input hold	7	—	ns
DS15	DSPI_SS active to DSPI_SOUT driven	—	38	ns </td
DS16	DSPI_SS inactive to DSPI_SOUT not driven	—	38	ns

**Figure 21. DSPI classic SPI timing — slave mode**

3.9.3 I²C

See [General switching specifications](#).

3.9.4 UART

See [General switching specifications](#).

3.10 Kinetis Motor Suite (KMS)

Pinout

100 LQFP	64 LQFP	48 LQFP	Pin Name	Default	ALT0	ALT1	ALT2	ALT3	ALT4	ALT5	ALT6	ALT7
30	—	—	VDD	VDD	VDD							
31	20	15	PTE24	ADCB_CH4	ADCB_CH4	PTE24	CAN1_TX	FTM0_CH0	XBAR0_IN2	I2C0_SCL	EWM_OUT_b	XBAR0_OUT4
32	21	16	PTE25/ LLWU_P21	ADCB_CH5	ADCB_CH5	PTE25/ LLWU_P21	CAN1_RX	FTM0_CH1	XBAR0_IN3	I2C0_SDA	EWM_IN	XBAR0_OUT5
33	—	—	PTE26	DISABLED		PTE26						
34	22	17	PTA0	JTAG_TCLK/ SWD_CLK		PTA0	UART0_CTS_b/ UART0_COL_b	FTM0_CH5	XBAR0_IN4	EWM_IN		JTAG_TCLK/ SWD_CLK
35	23	18	PTA1	JTAG_TDI		PTA1	UART0_RX	FTM0_CH6	CMP0_OUT		FTM1_CH1	JTAG_TDI
36	24	19	PTA2	JTAG_TDO/ TRACE_SWO		PTA2	UART0_TX	FTM0_CH7	CMP1_OUT		FTM1_CH0	JTAG_TDO/ TRACE_SWO
37	25	20	PTA3	JTAG_TMS/ SWD_DIO		PTA3	UART0_RTS_b	FTM0_CH0	XBAR0_IN9	EWM_OUT_b	FLEXPWMA_A0	JTAG_TMS/ SWD_DIO
38	26	21	PTA4/ LLWU_P3	NMI_b		PTA4/ LLWU_P3		FTM0_CH1	XBAR0_IN10	FTM0_FLT3	FLEXPWMA_B0	NMI_b
39	27	—	PTA5	DISABLED		PTA5		FTM0_CH2		CMP2_OUT		JTAG_TRST_b
40	—	22	VDD	VDD	VDD							
41	—	23	VSS	VSS	VSS							
42	28	—	PTA12	CMP2_IN0	CMP2_IN0	PTA12	CAN0_TX	FTM1_CH0				FTM1_QD_PHA
43	29	—	PTA13/ LLWU_P4	CMP2_IN1	CMP2_IN1	PTA13/ LLWU_P4	CAN0_RX	FTM1_CH1				FTM1_QD_PHB
44	—	—	PTA14	CMP3_IN0	CMP3_IN0	PTA14	SPI0_PCS0	UART0_TX				
45	—	—	PTA15	CMP3_IN1	CMP3_IN1	PTA15	SPI0_SCK	UART0_RX				
46	—	—	PTA16	CMP3_IN2	CMP3_IN2	PTA16	SPI0_SOUT	UART0_CTS_b/ UART0_COL_b				
47	—	—	PTA17	ADCA_CH7e	ADCA_CH7e	PTA17	SPI0_SIN	UART0_RTS_b				
48	30	—	VDD	VDD	VDD							
49	31	—	VSS	VSS	VSS							
50	32	24	PTA18	EXTAL0	EXTAL0	PTA18	XBAR0_IN7	FTM0_FLT2	FTM_CLKIN0	XBAR0_OUT8	FTM3_CH2	
51	33	25	PTA19	XTAL0	XTAL0	PTA19	XBAR0_IN8	FTM1_FLT0	FTM_CLKIN1	XBAR0_OUT9	LPTMR0_ALT1	
52	34	26	RESET_b	RESET_b	RESET_b							
53	35	27	PTB0/ LLWU_P5	ADCB_CH2	ADCB_CH2	PTB0/ LLWU_P5	I2C0_SCL	FTM1_CH0			FTM1_QD_PHA	UART0_RX
54	36	28	PTB1	ADCB_CH3	ADCB_CH3	PTB1	I2C0_SDA	FTM1_CH1	FTM0_FLT2	EWM_IN	FTM1_QD_PHB	UART0_TX

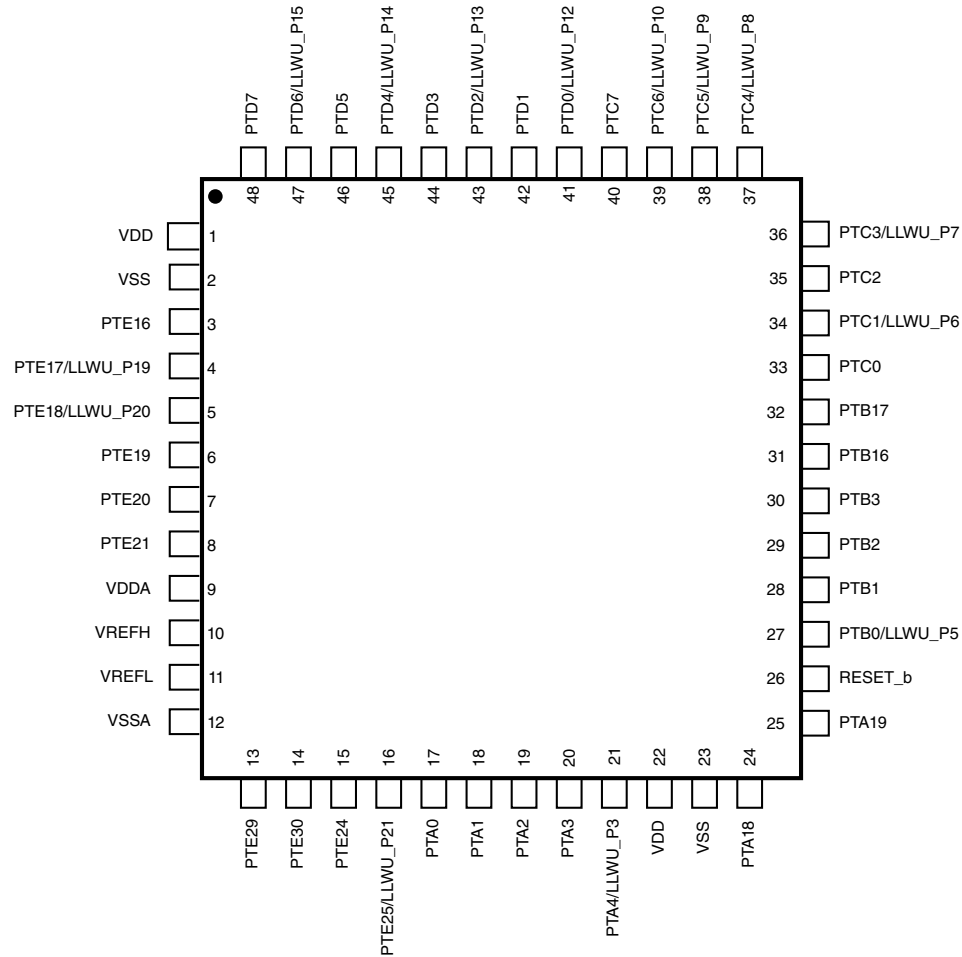


Figure 24. 48-pin LQFP

6 Ordering parts

Field	Description	Values
S	Software type	• P = KMS-PMSM and BLDC • (Blank) = Not software enabled
N	Packaging type	• R = Tape and reel • (Blank) = Trays

7.4 Example

This is an example part number:

MKV46F256VLL16

8 Terminology and guidelines

8.1 Definition: Operating requirement

An *operating requirement* is a specified value or range of values for a technical characteristic that you must guarantee during operation to avoid incorrect operation and possibly decreasing the useful life of the chip.

8.1.1 Example

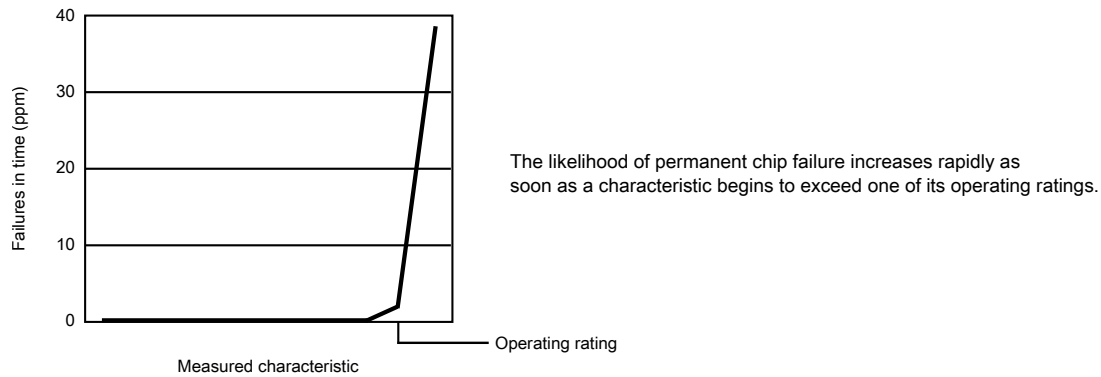
This is an example of an operating requirement:

Symbol	Description	Min.	Max.	Unit
V _{DD}	1.0 V core supply voltage	0.9	1.1	V

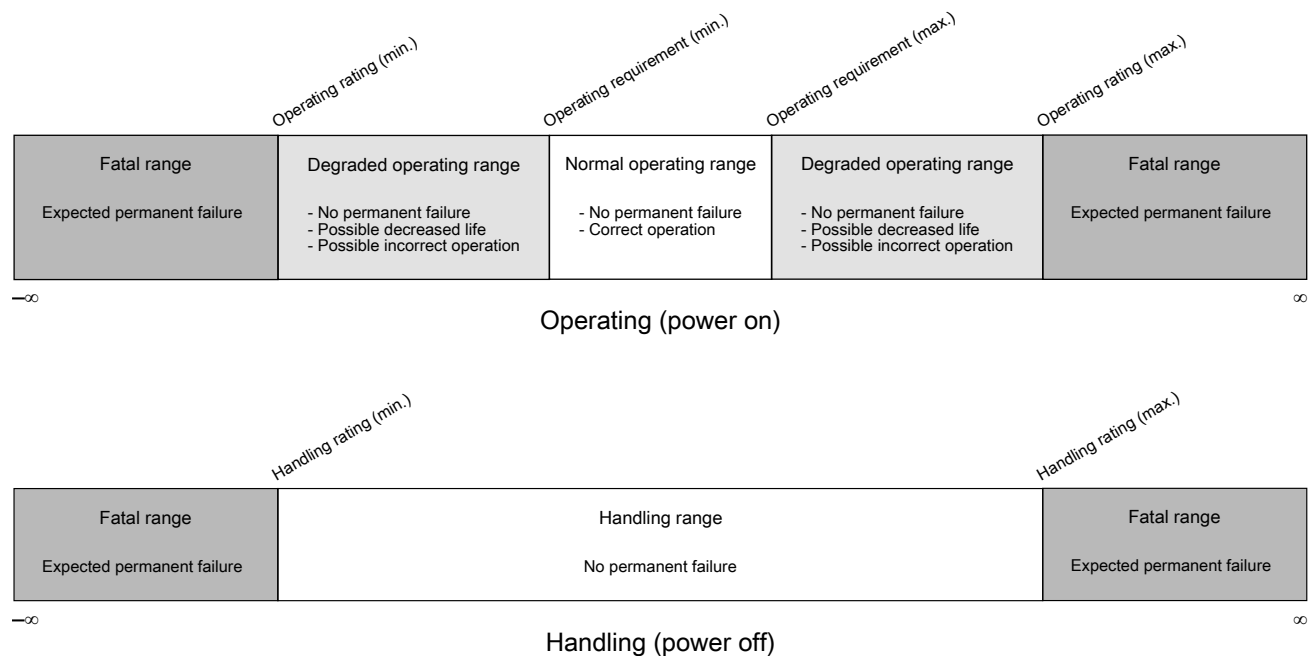
8.2 Definition: Operating behavior

Unless otherwise specified, an *operating behavior* is a specified value or range of values for a technical characteristic that are guaranteed during operation if you meet the operating requirements and any other specified conditions.

8.5 Result of exceeding a rating



8.6 Relationship between ratings and operating requirements



8.7 Guidelines for ratings and operating requirements

Follow these guidelines for ratings and operating requirements:

- Never exceed any of the chip's ratings.

Table 43. Revision history (continued)

Rev. No.	Date	Substantial Changes
		- Obtaining package dimensions - Pinout - In table "Power consumption operating behaviors", removed the text "Maximum core frequency of 150 Mhz" from note for I_{DDA}. - In table "Typical device clock specifications", removed information about High Speed run mode.
2	8/2015	- Updated instances of operating frequency from 150 MHz to 168 Mhz - Changed document number from "KV4XP100M150" to "KV4XP100M168" due to the change in operating frequency - Part numbers ending with "15" changed to ending with "16" - Removed instances of MKV45, MKV43, and MKV40 part numbers - Updated MKV41 part numbers to MKV42 - Added part numbers MKV44F256VLL16 and MKV44F256VLH16 - Updated table "Orderable part numbers summary" - In table Recommended Operating Conditions : - Updated minimum digital supply voltage to 1.71 V - Added footnote numbers 2 and 3 - Removed rows for I_{OH}, I_{OL}, N_F, T_R, and t_{FLRET} - Updated table Voltage and current operating behaviors - Updated table Power mode transition operating behaviors - Updated table Power consumption operating behaviors - Updated table EMC radiated emissions operating behaviors - Updated table Typical device clock specifications - Updated table Thermal attributes - Updated the PLL section of table MCG specifications - Updated t_{ersall} value in table Flash timing specifications — commands - Added note to section 12-bit cyclic Analog-to-Digital Converter (ADC) parameters - Updated I_{DDA_DACLP} and I_{DDA_DACHP} values in table 12-bit DAC operating behaviors - Updated the pinouts - Added section Enhanced NanoEdge PWM characteristics
3	06/2016	- Changed occurrences of Freescale to NXP - In the features list, added a section for "Kinetis Motor Suite" - Added section Kinetis Motor Suite (KMS) - In table 12-bit ADC electrical specifications, changed typical value of ENOB from 9.5 to 9.1